

**IGBT** 

# FGL60N100BNTD

## **NPT-Trench IGBT**

## **General Description**

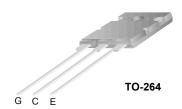
Trench insulated gate bipolar transistors (IGBTs) with NPT technology show outstanding performance in conduction and switching characteristics as well as enhanced avalanche ruggedness. These devices are well suited for Induction Heating ( I-H ) applications

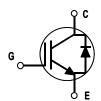
#### **Features**

- · High Speed Switching
- Low Saturation Voltage :  $V_{CE(sat)}$  = 2.5 V @  $I_C$  = 60A
- · High Input Impedance
- Built-in Fast Recovery Diode

## **Application**

Micro- Wave Oven, I-H Cooker, I-H Jar, Induction Heater, Home Appliance





# Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Description  Collector-Emitter Voltage		FGL60N100BNTD	Units
$V_{CES}$			1000	V
$V_{GES}$	Gate-Emitter Voltage		± 25	V
	Collector Current	@ T <sub>C</sub> = 25°C	60	Α
I <sub>C</sub>	Collector Current	@ T <sub>C</sub> = 100°C	42	Α
I <sub>CM (1)</sub>	Pulsed Collector Current		200	Α
I <sub>F</sub>	Diode Continuous Forward Current	@ T <sub>C</sub> = 100°C	15	Α
I <sub>F</sub> P <sub>D</sub>	Maximum Power Dissipation	@ T <sub>C</sub> = 25°C	180	W
	Maximum Power Dissipation	@ T <sub>C</sub> = 100°C	72	W
T <sub>J</sub>	Operating Junction Temperature		-55 to +150	°C
T <sub>stg</sub>	Storage Temperature Range		-55 to +150	°C
TL	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 second	300	°C	

#### Notes

(1) Repetitive rating : Pulse width limited by max. junction temperature

## **Thermal Characteristics**

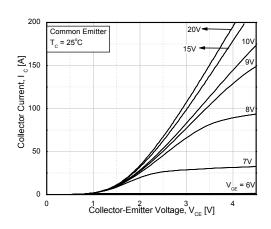
Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction-to-Case		0.69	°C/W
$R_{\theta JC}(DIODE)$	Thermal Resistance, Junction-to-Case		2.08	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		25	°C/W

Symbol	Parameter	Min.	Тур.	Max.	Units	
Off Cha	racteristics					
BV <sub>CES</sub>	Collector Emitter Breakdown Voltage	$V_{GE} = 0V, I_C = 1mA$	1000			V
I <sub>CES</sub>	Collector Cut-Off Current	V <sub>CE</sub> = 1000V, V <sub>GE</sub> = 0V			1.0	mΑ
I <sub>GES</sub>	G-E Leakage Current	$V_{GE} = \pm 25, V_{CE} = 0V$			± 500	nA
On Cha	racteristics					
V <sub>GE(th)</sub>	G-E Threshold Voltage	$I_C$ = 60mA, $V_{CE}$ = $V_{GE}$	4.0	5.0	7.0	V
	Collector to Emitter	I <sub>C</sub> = 10A, V <sub>GE</sub> = 15V		1.5	1.8	V
$V_{CE(sat)}$	Saturation Voltage	I <sub>C</sub> = 60A, V <sub>GE</sub> = 15V		2.5	2.9	V
<b>Dynami</b> C <sub>ies</sub>	C Characteristics Input Capacitance	T.,		6000		pF
C <sub>oes</sub>	Output Capacitance	$V_{CE} = 10V, V_{GE} = 0V,$		260		pF
_		√ f = 1MHz		000		
C <sub>res</sub>	Reverse Transfer Capacitance	=		200		pF
C <sub>res</sub> Switchii	Reverse Transfer Capacitance  ng Characteristics	· ·····-		200		•
	ng Characteristics Turn-On Delay Time			140		•
Switchii	ng Characteristics	V <sub>CC</sub> = 600 V, I <sub>C</sub> = 60A,				pF
Switching t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub>	ng Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time	$V_{CC} = 600 \text{ V}, I_{C} = 60\text{A},$ $R_{G} = 51\Omega, V_{GE} = 15\text{V},$		140		pF
Switching t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub>	ng Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	V <sub>CC</sub> = 600 V, I <sub>C</sub> = 60A,		140 320		pF ns ns
Switching  t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>a</sub>	ng Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time	$V_{CC} = 600 \text{ V}, I_{C} = 60\text{A},$ $R_{G} = 51\Omega, V_{GE} = 15\text{V},$ Resistive Load, $T_{C} = 25^{\circ}\text{C}$		140 320 630		ns ns ns
Switchi	ng Characteristics Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time	$V_{CC} = 600 \text{ V}, I_{C} = 60\text{A},$ $R_{G} = 51\Omega, V_{GE} = 15\text{V},$		140 320 630 130	   250	ns ns ns

# Electrical Characteristics of DIODE $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
V	Diode Forward Voltage	I <sub>F</sub> = 15A		1.2	1.7	V
$V_{FM}$	Diode i orward voltage	I <sub>F</sub> = 60A		1.8	2.1	V
t <sub>rr</sub>	Diode Reverse Recovery Time	I <sub>F</sub> = 60A di/dt = 20 A/us		1.2	1.5	μS
l <sub>R</sub>	Instantaneous Reverse Current	VRRM = 1000V		0.05	2	μΑ

FGL60N100BNTD Rev.A1 www.fairchildsemi.com



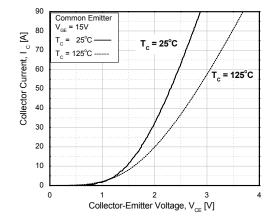
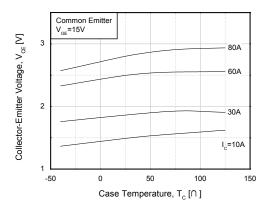


Fig 1. Typical Output Characteristics

Fig 2. Typical Saturation Voltage Characteristics



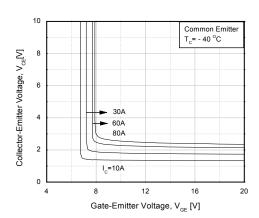
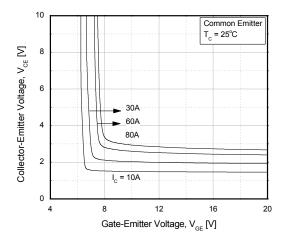


Fig 3. Saturation Voltage vs. Case
Temperature at Varient Current Level

Fig 4. Saturation Voltage vs.  $V_{\text{GE}}$ 



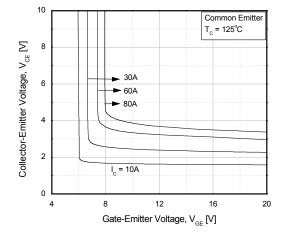
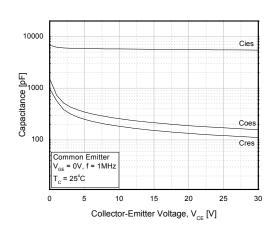


Fig 5. Saturation Voltage vs.  $V_{\text{GE}}$ 

Fig 6. Saturation Voltage vs.  $V_{\text{GE}}$ 

FGL60N100BNTD Rev.A1



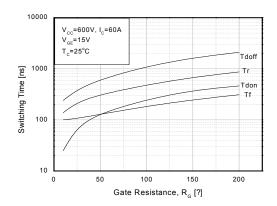
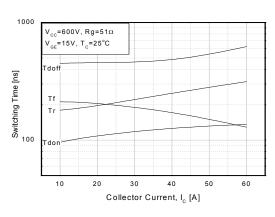


Fig 7. Capacitance Characteristics

Fig 8. Switching Characteristics vs. Gate Resistance



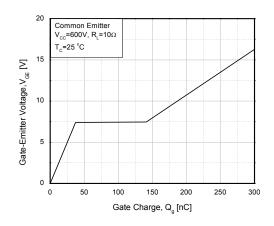
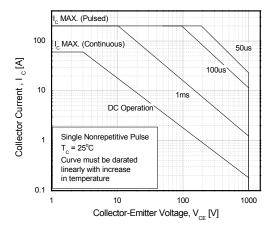


Fig 9. Switching Characteristics vs. Collector Current

Fig 10. Gate Charge Characteristics



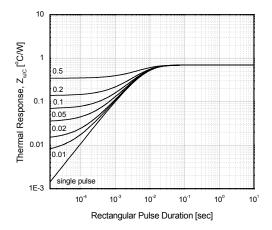


Fig 11. SOA Characteristics

Fig 12. Transient Thermal Impedance of IGBT

FGL60N100BNTD Rev.A1 www.fairchildsemi.com

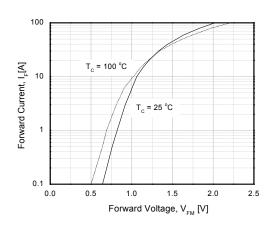
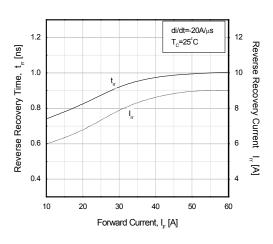


Fig 13. Forward Characteristics

Fig 14. Reverse Recovery Characteristics vs. di/dt



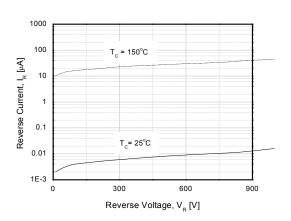


Fig 15. Reverse Recovery Characteristics vs. Forward Current

Fig 16. Reverse Current vs. Reverse Voltage

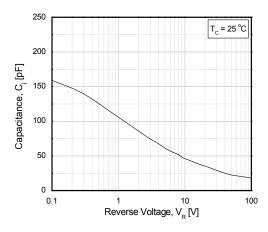
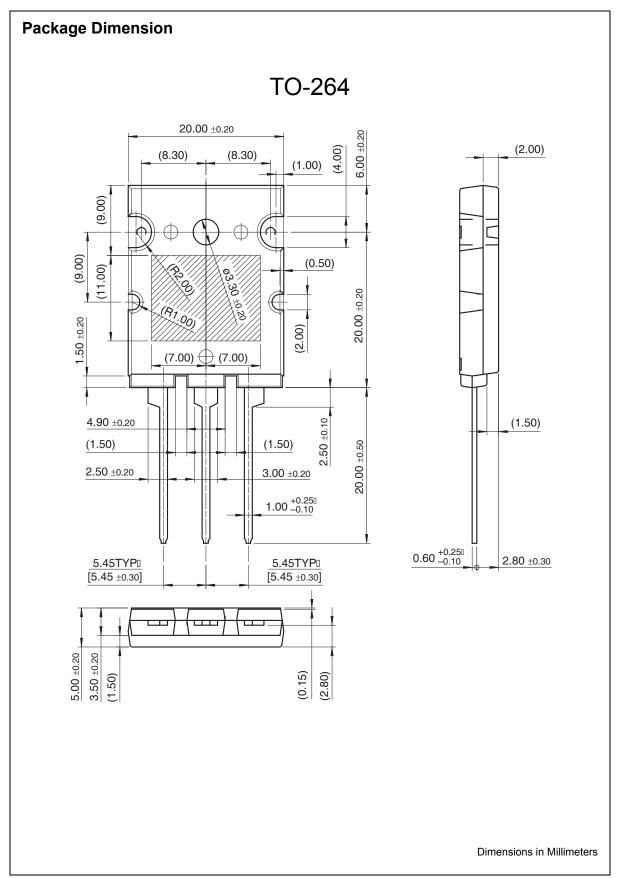


Fig 17. Junction capacitance

FGL60N100BNTD Rev.A1 www.fairchildsemi.com



#### **TRADEMARKS**

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACEx™	FACT Quiet Series™	ISOPLANAR™	POP™	Stealth™
ActiveArray™	FAST <sup>®</sup>	LittleFET™	Power247™	SuperFET™
Bottomless™	FASTr™	MICROCOUPLER™	PowerSaver™	SuperSOT™-3
CoolFET™	FPS™	MicroFET™	PowerTrench®	SuperSOT™-6
CROSSVOLT™	FRFET™	MicroPak™	QFET <sup>®</sup>	SuperSOT™-8
DOME™	GlobalOptoisolator™	MICROWIRE™	QS™	SyncFET™
EcoSPARK™	GTO™	MSX™	QT Optoelectronics™	TinyLogic <sup>®</sup>
E <sup>2</sup> CMOS™	HiSeC™	MSXPro™	Quiet Series™	TINYOPTO™
EnSigna™	I <sup>2</sup> C™	OCX™	RapidConfigure™	TruTranslation™
FACT™	ImpliedDisconnect™	OCXPro™	RapidConnect™	UHC™
Across the board	. Around the world.™	OPTOLOGIC <sup>®</sup>	SILENT SWITCHER®	UltraFET <sup>®</sup>
The Power Franc	chise™	OPTOPLANAR™	SMART START™	VCX™
Programmable A	ctive Droop™	PACMAN™	SPM™	

#### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

#### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.
- 2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

# **PRODUCT STATUS DEFINITIONS**

#### **Definition of Terms**

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.

©2004 Fairchild Semiconductor Corporation Rev. 18



Search:

Go

DATASHEETS, SAMPLES, BUY

Home >> Find products >>

# FGL60N100BNTD

1000V, 60A NPT-Trench IGBT

#### Contents

- General description
- Features
- Applications
- Product status/pricing/packaging

#### Order Samples

- Models
- Qualification Support

#### **General description**

Trench insulated gate bipolar transistors (IGBTs) with NPT technology show outstanding performance in conduction and switching characteristics as well as enhanced avalanche ruggedness. These devices are well suited for Induction Heating (I-H) applications

#### back to top

#### **Features**

- High Speed Switching
- Low Saturation Voltage: V<sub>CF(sat)</sub> = 2.5 V @ I<sub>C</sub> = 60A
- High Input Impedance
- Built-in Fast Recovery Diode

#### back to top

#### **Applications**

Micro- Wave Oven, I-H Cooker, I-H Jar, Induction Heater, Home Appliance

#### back to top

Product status/pricing/packaging



# BUY

**Datasheet** Download this datasheet



e-mail this datasheet



This page Print version

#### **Related Links**

#### Request samples

How to order products

**Product Change Notices** (PCNs)

Support

Sales support

Quality and reliability

Design center

FGL60N100BNTD	Full Production	Full Production	\$4.90	<u>TO-264</u>	3	RAIL	Line 1: <b>\$Y</b> (Fairchild logo)
FGL60N100BNTDTU	Full Production	Full Production	\$4.97	<u>TO-264</u>	3	RAIL	Line 1: <b>\$Y</b> (Fairchild logo)

<sup>\*</sup> Fairchild 1,000 piece Budgetary Pricing

\*\* A sample button will appear if the part is available through Fairchild's on-line samples program. If there is no sample button, please contact a Fairchild distributor to obtain samples



Indicates product with Pb-free second-level interconnect. For more information click here.

Package marking information for product FGL60N100BNTD is available. Click here for more information .

#### back to top

#### Models

Package & leads Condition Temperature range		Vcc range	Software version	Revision date			
	PSPICE						
TO-264-3	<u>Electrical</u>	25°C	0V to 5V	9.2	May 28, 2004		

#### back to top

# **Qualification Support**

Click on a product for detailed qualification data

Product
FGL60N100BNTD
FGL60N100BNTDTU

#### back to top

© 2007 Fairchild Semiconductor

